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TEST REPORT

Application No.: ZEWM2310001619RG

Applicant: Beijing InHand Networks Technology Co., Ltd.

Address of Applicant: Room 501, floor 5, building 3, yard 18, ziyue road, chaoyang district, Beijing

Manufacturer: Beijing InHand Networks Technology Co., Ltd.

Address of Manufacturer: Room 501, floor 5, building 3, yard 18, ziyue road, chaoyang district, Beijing

EUT Description: 5G Fixed Wireless Access

Model No.: FWA02

> FWA03 FWA12 FWA32 FWA62 FWA92

Trade Mark:

inhand

FCC ID: 2AANY-FWA Standards: 47 CFR Part 2 47 CFR Part 96

Date of Receipt: 2023/11/02

Date of Test: 2023/11/07 to 2023/11/16

Date of Issue: 2023/11/21

Test Result: PASS *

In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:

Keny Xu Laboratory Manager



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Version

Revision Record							
Version	Version Chapter Date Modifier Remark						
01		2023/11/21		Original			

Prepared By	Jall Huang (Jack Huang) / Test Engineer			
Checked By	Flora Wang (Flora Wang) / Reviewer			





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Test Summary

2.1 LTE Band 48

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §96.41	EIRP ≤ 23dBm/10MHz	Section 1 of Appendix B.1	Pass
Peak-Average Ratio	§96.41	FCC: Limit≤13 dB	Section 2 of Appendix B.1	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 3 of Appendix B.1	Pass
Adjacent Channel Leakage Ratio	§96.41	the Adjacent Channel Leakage Ratio for End User Devices shall be at least 30 dB.	Section 4 of Appendix B.1	Pass
Band Edges Compliance	§2.1051, §96.41	for channel and frequency assignments made by a CBSD to End User Devices, the conducted power of any End User Device emission outside the fundamental emission (whether in or outside of the authorized band) shall not exceed –13 dBm/MHz within 0 to B megahertz (where B is the bandwidth in megahertz of the assigned channel or multiple contiguous channels of the End User Device) above the upper CBSD-assigned channel edge and within 0 to B megahertz below the lower CBSD-assigned channel edge.	Section 5 of Appendix B.1	Pass
Spurious Emission at Antenna Terminals	§2.1051, §96.41	for channel and frequency assignments made by a CBSD to End User Devices, the conducted power of any End User Device emission outside the fundamental emission (whether in or outside of the authorized band) shall not exceed -13 dBm/MHz within 0 to B megahertz (where B is the bandwidth in megahertz of the assigned channel or multiple contiguous channels of the End User Device) above the upper CBSD-assigned channel edge and within 0 to B megahertz below the lower CBSD-assigned channel edge. At all frequencies greater than B megahertz above the upper CBSD assigned channel edge and less than B megahertz below the lower CBSD-assigned channel edge, the conducted power of any End User Device emission shall not exceed -25 dBm/MHz. (2) Additional protection levels. Notwithstanding paragraph (e)(1) of this section, for CBSDs and End User Devices, the conducted power of	Section 6 of Appendix B.1	Pass



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		emissions below 3540 MHz or above 3710 MHz shall not exceed -25 dBm/MHz, and the conducted power of emissions below 3530 MHz or above 3720 MHz shall not exceed -40dBm/MHz.		
Field Strength of Spurious Radiation	§2.1053, §96.41	for channel and frequency assignments made by a CBSD to End User Devices, the conducted power of any End User Device emission outside the fundamental emission (whether in or outside of the authorized band) shall not exceed –13 dBm/MHz within 0 to B megahertz (where B is the bandwidth in megahertz of the assigned channel or multiple contiguous channels of the End User Device) above the upper CBSD-assigned channel edge and within 0 to B megahertz below the lower CBSD-assigned channel edge. At all frequencies greater than B megahertz above the upper CBSD assigned channel edge and less than B megahertz below the lower CBSD-assigned channel edge, the conducted power of any End User Device emission shall not exceed –25 dBm/MHz. (2) Additional protection levels. Notwithstanding paragraph (e)(1) of this section, for CBSDs and End User Devices, the conducted power of emissions below 3540 MHz or above 3710 MHz shall not exceed –25 dBm/MHz, and the conducted power of emissions below 3530 MHz or above 3720 MHz shall not exceed –40dBm/MHz.	Section 7 of Appendix B.1	Pass
Frequency Stability	§2.1055, §96.41	Within authorized bands of operation/ frequency block.	Section 8 of Appendix B.1	Pass

Remark:

According to the Declaration letter from client, these models are the same in these:appearance,PCB layout and basic software function; The only difference is that the products are used in different markets.

Therefore in this report only the Model No.(FWA02) was tested, and internal wiring were identical for all above items. Only different on model No. for marketing requirement.



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General Information 3

3.1 Details of Client

Applicant:	Beijing InHand Networks Technology Co., Ltd.
Address of Applicant:	Room 501, floor 5, building 3, yard 18, ziyue road, chaoyang district, Beijing
Manufacturer:	Beijing InHand Networks Technology Co., Ltd.
Address of Manufacturer:	Room 501, floor 5, building 3, yard 18, ziyue road, chaoyang district, Beijing

3.2 Test Location

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
Address:	No. 1 Workshop, M-10, Middle section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China
Post code:	518057
Test engineer:	Jinhua Wei, Xing Guo

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• Innovation, Science and Economic Development Canada

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.

• FCC -Designation Number: CN1336

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Designation Number: CN1336.

Test Firm Registration Number: 787754



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3.4 General Description of EUT

EUT Description:	5G Fixed Wireless A	5G Fixed Wireless Access						
	FWA02	FWA02						
	FWA03							
Model No.:	FWA12							
	FWA32							
	FWA62							
	FWA92							
Trade Mark:	inhand							
Hardware Version:	V1.2							
Software Version:	V2.0							
Power Supply:	DC 12V	DC 12V						
IMEI:	RF Conducted 862424050368280							
IIVILI.	RSE 862424050162766							
Antenna Type:	External rod antenn	a						
	LTE Band 48:	1.96d	Bi (Ant6);					
Antenna Gain:	Note:							
, unorma Gami	The antenna gain a manufacturer.	re deriv	red from the gain information	report provided by the				
	9kHz ~ 30MHz	Z	30MHz ~ 1000MHz	1000MHz ~ 2000MHz				
	(0.3dB)		(0.6dB)	(0.8dB)				
RF Cable:	2000MHz ~ 4000MHz		4000MHz ~ 6000MHz	6000MHz ~ 12750MHz				
	(1.1dB)	(1.1dB) (1.8dB) (2.6dB)						
	Above 12750MHz (3.5dB)							
Note:	`							

As above information is provided and confirmed by the applicant. SGS is not liable to the accuracy, suitability, reliability or/and integrity of the information.



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3.5 Test Mode

Test Mode Test Modes Description			
LTE/TM1	LTE system, QPSK modulation		
LTE/TM2	LTE system, 16QAM modulation		
LTE/TM3	LTE system, 64QAM modulation		
LTE/TM4 LTE system, 256QAM modulation			
Remark: The test mode(s) are selected according to relevant radio technology specifications.			

3.6 Test Environment

Environment Parameter	101 kPa Selected Values During Tests				
Relative Humidity	44-46 % RH Ambient				
Value	Temperature(°C) Voltage(V)				
NTNV	22~23	12			
LTLV	-30	9			
LTHV	-30	48			
HTLV	50	9			
HTHV	50	48			

Remark:

NV: Normal Voltage LV: Low Extreme Test Voltage HV: High Extreme Test Voltage LT: Low Extreme Test Temperature HT: High Extreme Test Temperature NT: Normal Temperature

3.7 Description of Support Units

Description	Manufacturer	Model No.				
Adapter	KUANTEN LIMTED KT36W120300US					
Remark: all above the information of table are provided by client.						



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3.8 Technical Specification

Characteristics	Description							
Radio System Type								
Currented Frequency Dense	Band		TX		RX			
Supported Frequency Range	LTE Band 48		3550 to	3700 MHz		3550 to 3	3550 to 3700 MHz	
Supported Channel Bandwidth	LTE Band 48		⊠5 MHz	z ⊠10 MHz	<u> </u>	15 MHz	⊠20 MHz	
Characteristics	Description							
Designation of Emissions	E-UTRA:	QP	SK	16QAM	64	QAM	256QAM	
(Remark: the necessary		4M:	50G7D	4M50W7D	4N	151W7D	4M51W7D	
bandwidth of which is the		8M95G7D		8M92W7D	8M	195W7D	8M92W7D	
worst value from the		13N	/16G7D	13M6W7D	13	M5W7D	13M5W7D	
measured occupied	LTE Band 48							
bandwidths for each type of		181	/0G7D	17M9W7D	17	M9W7D	17M9W7D	
channel bandwidth								
configuration.)								



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3.9 Test Frequencies

Test Mode	Bandwidth	TX / RX	RF Channel			
			Low (L)	Middle (M)	High (H)	
	5MHz	TX/RX	Channel 55265	Channel55990	Channel 56715	
			3552.5 MHz	3625.0 MHz	3697.5 MHz	
LTE David 40	10MHz 15MHz	TX/RX	Channel 55290	Channel55990	Channel 56690	
			3555.0 MHz	3625.0 MHz	3695.0 MHz	
LTE Band 48		TX/RX	Channel 55315	Channel55990	Channel 56665	
_			3557.5 MHz	3625.0 MHz	3692.5 MHz	
	20MHz	TX/RX	Channel 55340	Channel55990	Channel 56640	
		IA/KA	3560.0 MHz	3625.0 MHz	3690.0 MHz	



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Description of Tests

4.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.2.1

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Remark: Reference test setup 1



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4.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8.4

Calculate power in dBm by the following formula:

ERP (dBm) = Conducted Power (dBm) + antenna gain (dBd)

EIRP(dBm) = Conducted Power (dBm) + antenna gain (dBi)

EIRP=ERP+2.15dB



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4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2 & 4.3

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel). The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Remark: Reference test setup 1

Test Settings

- 1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5% of the expected OBW
- VBW ≥ 3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- The trace was allowed to stabilize
- 8. If necessary, steps 2 7 were repeated after changing the RBW such that it would be within
 - 1 5% of the 99% occupied bandwidth observed in Step 7



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4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to rms.

Remark: Reference test setup 1

Test Settings

- 1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
- 2. Span was set large enough so as to capture all out of band emissions near the band edge
- 3. RBW > 1% of the emission bandwidth
- VBW > 3 x RBW
- Detector = RMS
- Number of sweep points ≥ 2 x Span/RBW
- Trace mode = trace average for continuous emissions, max hold for pulse emissions
- 8. Sweep time = auto couple
- The trace was allowed to stabilize



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4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel). The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Remark: Reference test setup 1

Test Settings

- 1. Start frequency was set to 9kHz and stop frequency was set to at least 10* the fundamental frequency(Separated into at least two plots per channel)
- 2. Detector = RMS
- 3. Trace mode = trace average for continuous emissinos, max hold for pulse emissions
- 4. Sweep time = auto couple
- 5. The trace was allowed to stabilize
- 6. Please see test notes below for RBW and VBW settings



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4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.2

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span

Remark: Reference test setup 1

Test Settings

- 1. The signal analyzer's CCDF measurement profile is enabled
- Frequency = carrier center frequency
- Measurement BW > Emission bandwidth of signal
- The signal analyzer was set to collect one million samples to generate the CCDF curve
- The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power



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4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). Test the EUT in the lowest channel, the middle channel ,the Highest channel.
- 5). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 6). Repeat above procedures until all frequencies measured was complete.

E (dBμV/m) = Measured amplitude level (dBμV) + (Cable Loss (dB) + Antenna Factor (dB/m) – AMP(dB)) EIRP (dBm) = E (dBμV/m) + 20 log D - 104.8; where D is the measurement distance in meters

Above 1GHz test procedure as below:

- 1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

E (dBμV/m) = Measured amplitude level (dBμV) + (Cable Loss (dB) + Antenna Factor (dB/m) – AMP(dB)) EIRP (dBm) = E (dB μ V/m) + 20 log D - 104.8; where D is the measurement distance in meters

- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete

Remark1: Reference test setup 2

Remark2: The emission below 18G were measured at a 3m test distance, while emissions above 18GHz were measured at a 1m test distance. At a measurement distance of 1 meter the limit line was increased by 20*LOG(3/1) = 9.54 dB.

Remark: Reference test setup 2

Remark:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & AMP. The basic equation with a sample calculation is as follows:

AF = Antenna Factor(dB/m)

Factor = Cable Factor(dB) - Preamplifier (dB)

Level = Reading Level + AF + Factor -95.26

Margin = Limit – Level

2) Scan from 9kHz to 40GHz, The disturbance between 9KHz to 30MHz and 18GHz to 40GHz was very low, and the harmonics were the highest point could be found when testing, so only the harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

3) All modes have been tested, but only the worst case data displayed in this report.



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4.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; Section 9

- . The frequency stability of the transmitter is measured by:
- a.) Temperature: The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) Primary Supply Voltage: The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification - The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Remark: Reference test setup 3

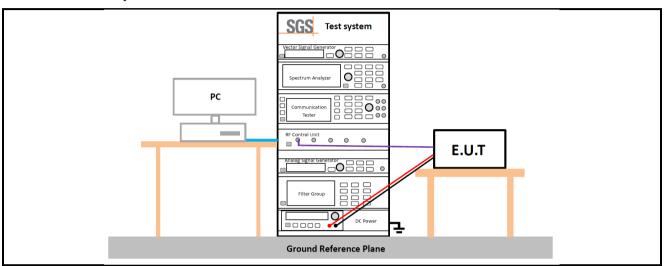


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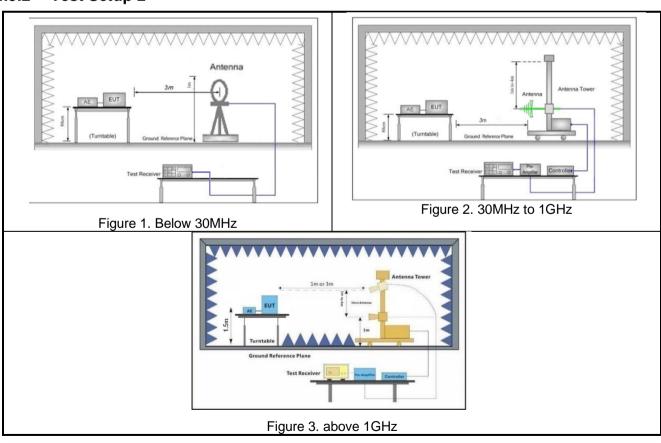
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4.9 Test Setups

4.9.1 **Test Setup 1**



4.9.2 **Test Setup 2**





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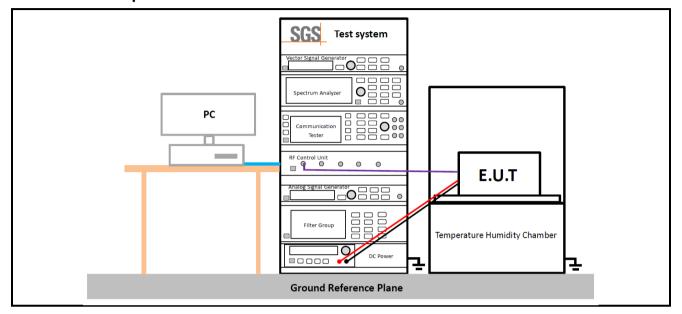


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4.9.3 **Test Setup 3**





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4.10Test Conditions

Transmit Output Power Data - Average Power, Total				
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1;LTE/TM2;LTE/TM3;LTE/TM4			
	Peak-to-Average Ratio			
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1;LTE/TM2;LTE/TM3;LTE/TM4			
Bandwidth - Occupied Bandwidth				
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1;LTE/TM2;LTE/TM3;LTE/TM4			
	Bandwidth - Emission Bandwidth			
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1;LTE/TM2;LTE/TM3;LTE/TM4			
Adjacent Channel Leakage Ratio				
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1			
Band Edges Compliance				



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Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	L, H (L= low channel, H= high channel)		
Test Mode	LTE/TM1		
	Spurious Emission at Antenna Terminals		
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)		
Test Mode	LTE/TM1		
Field Strength of Spurious Radiation			
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 2		
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)		
Test Mode	LTE/TM1 Remark: All bandwidth and modulation of LTE have been pre tested, and only the worst results are reflected in the report.		
	Frequency Stability		
Test Case	Test Conditions		
Test Environment	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage (2) VL, VN and VH of Rated Voltage at Ambient Climate.		
Test Setup	Test Setup 3		
RF Channels (TX)	M (M= middle channel)		
Test Mode	LTE/TM1 The report only show the bandwidth with the worst case.		



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Main Test Instruments

RF Test System					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy/mm/dd)	Cal.Due date (yyyy/mm/dd)
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	HTC-1	SZ-WRG-M-032	2023/02/17	2024/02/16
Spectrum Analyzer	Rohde & Schwarz	FSV	SZ-WRG-M-012	2023/02/16	2024/02/15
DC power supply	HYELEC	HY3005B	SZ-WRG-M-044	2023/09/14	2024/09/13
Digital Multimeter	VICTOR	VC890C	374464013173	2023/02/06	2024/02/05
Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	SZ-WRG-M-033	2023/02/16	2024/02/15
Wideband Radio Communication Tester	Anristu	MT8821C	SZ-WRG-M-042	2023/05/25	2024/05/24
Programmable Temperature & Humidity Chamber	Votsch Industrietechnik GmbH	VT 4002	SZ-WRG-M-017	2022/12/22	2023/12/21
Signal Generator	KEYSIGHT	N5182A	SZ-WRG-M-041	2023/02/16	2024/02/15
Signal &Spectrum Analyzer	Rohde & Schwarz	FSV	SZ-WRG-M-048	2023/02/16	2024/02/15



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RSE Test System					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy/mm/dd)	Cal.Due date (yyyy/mm/dd)
EMI TEST RECEIVER	Rohde & Schwarz	ESR	SZ-WRG-M-047	2023/02/16	2024/02/15
Signal &Spectrum Analyzer	Rohde & Schwarz	FSV	SZ-WRG-M-048	2023/02/16	2024/02/15
Low Noise Amplifier 9K- 3GHz	Tonscend	TAP9K3G32	SZ-WRG-M-049	2023/02/16	2024/02/15
Low Noise Amplifier 30M- 8GHz	Tonscend	TAP30M8G30	SZ-WRG-M-050	2023/02/16	2024/02/15
Low Noise Amplifier 1G- 18GHz	Tonscend	TAP01018050	SZ-WRG-M-051	2023/02/16	2024/02/15
Low Noise Amplifier 18G- 40GHz	Tonscend	TAP18040048	SZ-WRG-M-052	2023/02/16	2024/02/15
Active Loop Antenna 9kHz- 30MHz	SCHWARZBECK	FMZB 1519B	SZ-WRG-M-053	2022/01/16	2024/01/15
TRILOG Breitband Antenne 30MHz-1GHz	SCHWARZBECK	VULB 9168	SZ-WRG-M-054	2022/01/16	2024/01/15
Double Ridge Horn Antenna 1GHz-18GHz	SCHWARZBECK	BBHA 9120 D	SZ-WRG-M-055	2022/01/16	2024/01/15
SHF-EHF Horn 15GHz-40GHz	SCHWARZBECK	BBHA 9170	SZ-WRG-M-056	2022/01/16	2024/01/15
RSE Test Software	Tonscend	JS32-RSE V4.0.0	SZ-WRG-S-058	NCR	NCR
RE Test Software	Tonscend	JS36-RSE V5.0.0.1	SZ-WRG-S-059	NCR	NCR
Radio Communication Tester	Anritsu	MT8821C	SZ-WRG-M-042	2023/05/25	2024/05/24



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6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in

accordance with the recommendations of ISO 17025 as following:

No.	Item	Measurement Uncertainty
1	Radio Frequency	± 9.84Hz
2	Duty cycle	± 0.185%
3	Occupied Bandwidth	± 0.20%
4	RF conducted power	± 0.42dB
5	RF power density	± 1.97dB
6	Conducted Spurious emissions	± 0.42dB
		±4.8dB (30MHz-1GHz)
7	Radiated Spurious emission test (UE)	±4.68dB (1GHz-6GHz)
		±4.52dB (6GHz-18GHz)
		±5.26dB (18GHz-40GHz)

Remark:

The U_{lab} (lab Uncertainty) is less than U_{cispr/ETSI} (CISPR/ETSI Uncertainty), so the test results

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;

- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.



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7 Appendixes

Appendix A.3	WWAN Setup Photos
Appendix B.1	LTE Band 48

---End of Report---

